

European Committee for Electrotechnical Standardization (CENELEC)
Cenelec Electronic Components Committee

CECC

Système Harmonisé d'Assurance de la Qualité
des Composants Electroniques

SPECIFICATION PARTICULIERE:

**VARISTANCES BASSE
TENSION POUR MATERIEL
TELEPHONIQUE**

Disques avec sorties par fils: protégé
0,1 W: Niveau d'assurance de qualité P

Harmonized System of Quality Assessment for
Electronic Components

DETAIL SPECIFICATION:

**LOW VOLTAGE VARISTORS
PRIMARILY FOR TELEPHONY
APPLICATIONS**

Disc type, wire terminations: protected
0,1 W: Assessment level P

Harmonisiertes Gütebestätigungssystem für
Bauelemente der Elektronik

**BAUARTSPEZIFIKATION:
NIEDERSpannungs-
VARISTOREN
VORZUGSWEISE FÜR
TELEPHONIE-ANWENDUNGEN**

Scheibenbauform mit Anschlußdrähten: lackumhüllt
0,1 W: Gütebestätigungsstufe P



1 Edition
Issue
Ausgabe

CECC 42 101-803

1982

Information about the System may be obtained from:



FEN e.V. Secretariat
and
CECC General Secretariat
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or from the National Authorized Institutions
of the participating countries listed
who can supply copies of:

- 1 The Internal Regulations of the FEN e.V.
- 2 The Rules of Procedure of the System
- 3 CECC Specifications of the FEN and National Specifications for the System
- 4 CECC 00 200: Qualified Products List (QPL)
- 5 CECC 00 300: CECC Publications and their related national documents
- 6 Other CECC Publications and publicity documents

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FOREWORD

The CENELEC Electronic Components Committee (CECC) is composed of those member countries of the European Committee for Electrotechnical Standardization (CENELEC) who wish to take part in a harmonized System for electronic components of assessed quality.

The object of the System is to facilitate international trade by the harmonization of the specifications and quality assessment procedures for electronic components, and by the grant of an internationally recognized Mark, or Certificate, of Conformity. The components produced under the System are thereby accepted by all member countries without further testing.

This specification has been formally approved by the CECC, and has been prepared for those countries taking part in the System who wish to issue national harmonized specifications for LOW VOLTAGE VARISTORS PRIMARILY FOR TELEPHONY-APPLICATIONS (ASSESSMENT LEVEL P). It should be read in conjunction with document CECC 00 100: Basic Rules (1974).

At the date of printing of this document the member countries of the CECC are Austria, Belgium, Denmark, Finland, France, Germany, Ireland, Italy, the Netherlands, Norway, Sweden, Switzerland, and the United Kingdom. Copies of it can be obtained from the addresses shown on the inside cover.

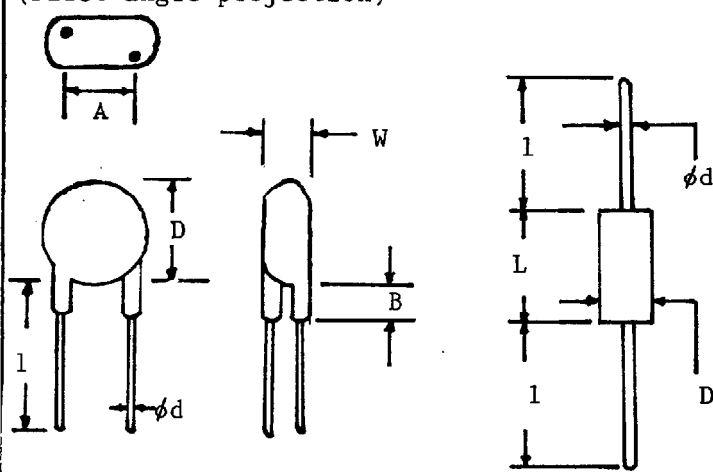
PREFACE

This detail specification was prepared by CECC Working Group 4 : "Resistors".

It is one of a series of detail specifications for low voltage varistors primarily for telephony applications, all relating to the generic specification printed as CECC 42 000, the sectional specification printed as CECC 42 100 and the blank detail specification printed as CECC 42 101.

The text of this specification was circulated to the CECC for voting in the document listed below and was ratified by the CECC for publishing as a CECC Specification.

<u>Document</u>	<u>Voting date</u>	<u>Report on the voting</u>
CECC(Secretariat)825	October 1979	CECC(Secretariat)954

Copies of this specification can be obtained from : CECC General Secretariat Stresemannallee 15 D-6000 Frankfurt/Main 70 or from the addresses shown on the inside cover.	CECC 42 101 - 803 1982
ELECTRONIC COMPONENTS OF ASSESSED QUALITY IN ACCORDANCE WITH CECC 42 000, GENERIC SPECIFICATION FOR VARISTORS AND CECC 42 100, SECTIONAL SPECIFICATION FOR LOW VOLTAGE VARISTORS PRIMARILY FOR TELEPHONY APPLICATION.	Issue 1
Outline and dimensions : (See Table 1) (First angle projection)  STYLES AA, AB, AC, AD, AE & AF STYLE BA	LOW VOLTAGE VARISTORS PRIMARILY FOR TELEPHONY APPLICATIONS TYPICAL CONSTRUCTION : ZINC OXIDE DISC TYPE, WIRE TERMINATIONS, PROTECTED 0,1 W ASSESSMENT LEVEL 'P'

For ordering information, see Clause 4.

NOTE 1 : Other shapes are permitted within the dimensional envelope shown.

NOTE 2 : The non-dimensioned details do not affect the use of the device.

TABLE 1

Style	Max. Current at reference voltage (48 V) (mA)	Peak Current at voltage (135 V) under pulse conditions (mA)	Dimensions (mm)						
			D max.	W max.	L max.	d nom. (See IEC 301)	l min.	B max.	A
AA	0,01	152	7	3	-	0,6	12	6	2,54 $\pm$ 0,5
AB	0,01	152	7	3	-	0,6	**	**	**
AC	0,01	152	8,5	6	-	0,6	12	6	2,54 $\pm$ 0,5
AD	0,01	152	8,5	6	-	0,6	**	**	**
AE	0,01	152	5,5	3	-	0,6	25	6	2,54 $\pm$ 0,5
AF	0,01	152	8,5	6	-	0,6	25	6	5,08 $\pm$ 0,5
BA	0,01	152	3,7	-	8,5	0,8	25	-	-

** To be in accordance with ordering information.

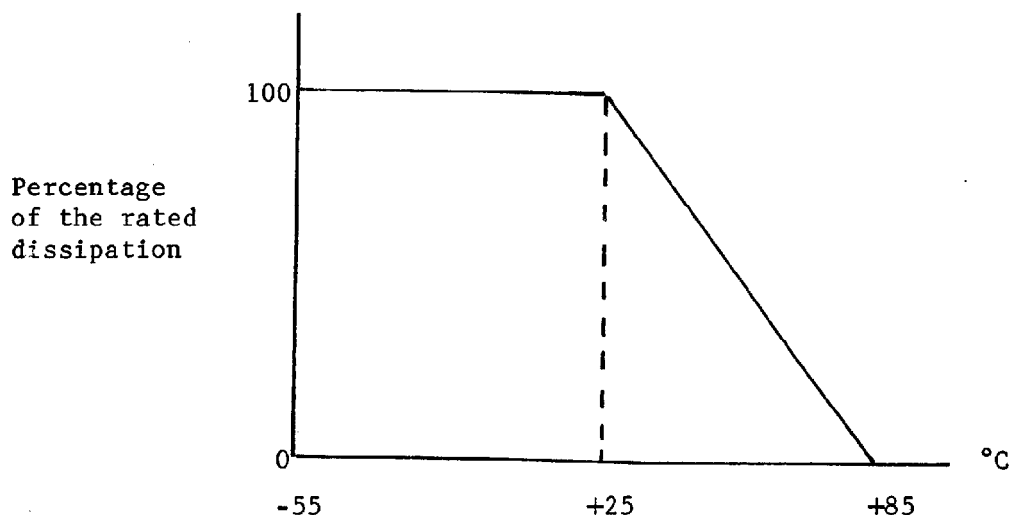
See the relevant Qualified Products List for the availability of
components qualified to this detail specification.

1 RATINGS AND CHARACTERISTICS

Climatic category	55/085/56
Reference voltage	48 V d.c.
Rated dissipation (at 25 °C)	0,1 W
Temperature coefficient of voltage (measured at 1 mA)	0,1%/°C max.
Non-linearity	135 V _{max.}

1.1 De-rating curve

Varistors covered by this specification are derated according to the curve :

2 MARKING

The marking of the component and the package shall be in accordance with the requirements of 2.4 of CECC 42 000.

The values for the reference voltage (48 V d.c.) and the current at reference voltage (0,01 mA) shall be marked on the varistor either :

1) as 48 V m01

or

2) the body being coloured white completely.

3 RELATED DOCUMENTS

CECC 00 006	1981	Basic specification : Environmental test procedures
CECC 42 000	1978	Generic specification : Varistors
CECC 42 100	1978	Sectional specification : Low voltage varistors primarily for telephony applications

IEC 68-2-20	1979	Basic environmental testing procedures. Test T : Soldering.
IEC 301	1971	Preferred diameters of wire terminations of capacitors and resistors.
IEC 410	1973	Sampling plans and procedures for inspection by attributes.

4 ORDERING INFORMATION

Orders for varistors covered by this specification shall contain the following information :

- reference voltage
- maximum current at reference voltage
- number of this detail specification and style reference
- for styles AB and AD, the values of dimensions l, A and B

5 CERTIFIED TEST RECORDS (RCE)

Certified test records shall be prepared in accordance with 3.5 of CECC 42 000.

6 INSPECTION REQUIREMENTS (See Table 2)

When it is desired to obtain qualification approval by adopting the fixed sample size procedure (see 3.3.3 of CECC 42 000), use shall be made of the test schedule given for that purpose in CECC 42 100.

The conditions of test and performance requirements shall be identical to those prescribed for quality conformance inspection in the detail specification.

(See Notes 1 and 2)

Clause Number and Test	Conditions of test	IL	AQL	Performance Requirements
GROUP A INSPECTION				
To be conducted on a sampling basis, lot-by-lot				
Sub-Group A1 (Non-destructive)		II	4%	
4.2.1 Visual examination				As in 4.2.1
Sub-Group A2 (Non-destructive)		II	1%	
4.2.2 Marking				As in 4.2.2
4.2.3 Dimensions (gauging)	Dimensions A, B and D			As specified in Table 1
Sub-Group A3 (Non-destructive)		II	1,5%	
Cl.2 Voltage under pulse conditions	Peak current : 152 mA			$V_{max.} : 135 \text{ V}$
4.3 Current at reference voltage	Reference voltage : 48 V			$I : \leq 0,01 \text{ mA}$
Sub-Group A4 (Non-destructive)		S-1	4%	
4.2.4 Dimensions (detail)	Dimensions ϕd , W and l			As specified in Table 1
GROUP B INSPECTION				
(See Note 6)				
To be conducted on a sampling basis, lot-by-lot				
Sub-Group B1 (Destructive)		S-3	2,5%	
4.11 Robustness of terminations	Tensile and bending tests (See Note 5) Visual examination Current at reference voltage Reference voltage : 48 V			As in 4.11.6 $\Delta I : \leq 40 \mu\text{A}$
4.10.1 Soldering - solderability	Solder bath method $230 \pm 10 ^\circ\text{C}$			The terminations shall be uniformly tinned.

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(See Notes 1, 2 and 3)

Clause Number and Test	Conditions of Test	IL	AQL	Performance Requirements
<u>Sub-Group B3 (Destructive)</u>		S-2	1,5%	As in Cl.1.4 $\Delta I : \leq 40\mu A$ $V_{max.}: 135 V$
Cl.1 Overload	Visual examination Current at reference voltage Reference voltage : 48 V Voltage under pulse conditions			
<u>GROUP C INSPECTION</u>		Sample size & criterion of acceptability		
		P	n	c
To be conducted on a sampling basis at the periodicity given in column 'P'				
<u>Sub-Group C1 (Destructive)</u>		6	8	1
Cl.3 Pulse endurance	Visual examination Current at reference voltage Reference voltage : 48 V Voltage under pulse conditions			As in Cl.3.4 $\Delta I : \leq 40 \mu A$ $V_{max.}: 135 V$
<u>Sub-Group C2 (Destructive)</u>		6	13	1
4.10.2 Soldering - resistance to solder heat	Method 1A of IEC 68-2-20 Visual examination Current at reference voltage Reference voltage : 48 V			As in 4.10.2.4 $\Delta I : \leq 40 \mu A$
4.12 Rapid change of temperature	$T_A : -55^{\circ}C$ $T_B : 85^{\circ}C$ Visual examination Current at reference voltage Reference voltage : 48 V			As in 4.12.4 $\Delta I : \leq 40 \mu A$

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(See notes 1 and 3)

Clause Number and Test	Conditions of Test	Sample size & criterion of acceptability			Performance Requirements						
		P	n	c							
<u>Sub-Group D3 (Non-destructive)</u> 4.5 Temperature coefficient of voltage	Measuring current : 1 mA	24	8	1	<table><tr><td>25/-55</td><td>25/85</td></tr><tr><td colspan="2">$\Delta V : \leq$</td></tr><tr><td>0,1%/°C</td><td>0,1%/°C</td></tr></table>	25/-55	25/85	$\Delta V : \leq$		0,1%/°C	0,1%/°C
25/-55	25/85										
$\Delta V : \leq$											
0,1%/°C	0,1%/°C										
<u>Sub-Group D4 (Destructive)</u> 4.14 Shock	Pulse shape : half sine Acceleration : 490 m/s ² Pulse duration : 11 ms (See Note 4) Visual examination Current at reference voltage Reference voltage : 48 V	24	6	1	As in 4.14.3 $\Delta I : \leq 40 \mu A$						
<u>Sub-Group D5 (Destructive)</u> 4.18 Flammability	(Under consideration)	24	5	0							

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